

Notice of References Cited	Application/Control No. 09/475,104	Applicant(s)/Patent Under Reexamination VODRAHALLI ET AL.	
	Examiner James M. Mitchell	Art Unit 2813	Page 1 of 1

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	B	US-6,226,187	05-2001	Questad et al.	361/707
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NON-PATENT DOCUMENTS

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	U	Jow, "Dielectric and Temperature Measurements During Microwaver Curing of Epoxy in a Sweeping Resonant Cqavity", 1987 IEEE, p. 465-468
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.